

<b>Notice of References Cited</b>	Application/Control No. 10/648,231	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Tuyen To	Art Unit 2825	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,175,947	01-2001	Ponnapalli et al.	716/5
*	C	US-5,900,633	05-1999	Solomon et al.	250/339.08
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NON-PATENT DOCUMENTS

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